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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/975,801	AGRAWAL ET AL.	
Examiner	Art Unit	
Jung Park	2661	

SEARCHED				
Class	Subclass	Date	Examiner	
370	331, 338, 349, 352, 401, 329	7/22/2005	JP	
370	473	7/22/2005	JP	
455	442, 436	7/22/2005	JP	
Above	UPDATED	12/14/2005	JP	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			-
	ce Search Printout	12/15/2005	JP

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Consulted with Chau N. for search 370/331, 338, 401	7/22/2005 (Updatedor 12/14/65)	JP	
Searched Internet for IEEE.	7/23/2005	JP	